

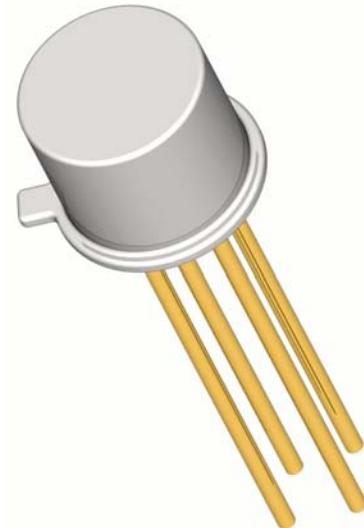
Description

SEMICOA Corporation offers:

- Screening and processing per MIL-PRF-19500 Appendix E
- JAN level (2N4261J)
- JANTX level (2N4261JX)
- JANTXV level (2N4261JV)
- JANS level (2N4261JS)
- QCI to the applicable level
- 100% die visual inspection per MIL-STD-750 method 2072 for JANTXV and JANS
- Radiation testing (total dose) upon request

Applications

- General purpose switching transistor
- Low power
- PNP silicon transistor

**Features**

- Hermetically sealed TO-72 metal can
- Also available in chip configuration
- Chip geometry 0014
- Reference document: MIL-PRF-19500/511

Benefits

- Qualification Levels: JAN, JANTX, JANTXV and JANS
- Radiation testing available

Absolute Maximum Ratings

T_c = 25°C unless otherwise specified

Parameter	Symbol	Rating	Unit
Collector-Emitter Voltage	V _{CEO}	15	Volts
Collector-Base Voltage	V _{CBO}	15	Volts
Emitter-Base Voltage	V _{EBO}	4.5	Volts
Collector Current, Continuous	I _C	30	mA
Power Dissipation, T _A = 25°C Derate linearly above 25°C	P _T	200 1.14	mW mW/°C
Thermal Resistance	R _{θJA}	0.86	°C/mW
Operating Junction Temperature Storage Temperature	T _J T _{STG}	-65 to +200	°C

ELECTRICAL CHARACTERISTICS

characteristics specified at $T_A = 25^\circ\text{C}$

Off Characteristics

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Collector-Emitter Breakdown Voltage	$V_{(\text{BR})\text{CEO}}$	$I_C = 10 \text{ mA}$	15			Volts
Collector-Base Cutoff Current	I_{CBO}	$V_{\text{CB}} = 15 \text{ Volts}$			10	μA
Collector-Emitter Cutoff Current	$I_{\text{CEX}1}$ $I_{\text{CEX}2}$ $I_{\text{CEX}3}$	$V_{\text{CE}} = 10 \text{ Volts}, V_{\text{BE}} = 0.4 \text{ Volts}$ $V_{\text{CE}} = 10 \text{ Volts}, V_{\text{BE}} = 2 \text{ Volts}$ $V_{\text{CE}} = 10 \text{ Volts}, V_{\text{BE}} = 2 \text{ Volts}, T_A = 150^\circ\text{C}$			50 5 5	nA nA μA
Emitter-Base Cutoff Current	I_{EBX}	$V_{\text{BE}} = 2 \text{ Volts}, V_{\text{CE}} = 10 \text{ Volts}$			5	nA
Emitter-Base Cutoff Current	I_{EBO}	$V_{\text{EB}} = 4.5 \text{ Volts}$			10	μA

On Characteristics

Pulse Test: Pulse Width = 300 μs , Duty Cycle < 2.0%

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
DC Current Gain	$h_{\text{FE}1}$ $h_{\text{FE}2}$ $h_{\text{FE}3}$ $h_{\text{FE}4}$	$I_C = 1 \text{ mA}, V_{\text{CE}} = 1 \text{ Volts}$ $I_C = 10 \text{ mA}, V_{\text{CE}} = 1 \text{ Volts}$ $I_C = 30 \text{ mA}, V_{\text{CE}} = 1 \text{ Volts}$ $I_C = 10 \text{ mA}, V_{\text{CE}} = 1 \text{ Volts}$ $T_A = -55^\circ\text{C}$	25 30 20 15		150	
Base-Emitter Voltage	$V_{\text{BE}1}$ $V_{\text{BE}2}$	$V_{\text{CE}} = 1 \text{ Volts}, I_C = 1 \text{ mA}$ $V_{\text{CE}} = 1 \text{ Volts}, I_C = 10 \text{ mA}$			0.8 1.0	Volts
Collector-Emitter Saturation Voltage	$V_{\text{CEsat}1}$ $V_{\text{CEsat}2}$	$I_C = 1 \text{ mA}, I_B = 0.1 \text{ mA}$ $I_C = 10 \text{ mA}, I_B = 1 \text{ mA}$			0.15 0.35	Volts

Dynamic Characteristics

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Magnitude – Common Emitter, Short Circuit Forward Current Transfer Ratio	$ h_{\text{FE}1} $ $ h_{\text{FE}2} $	$f = 100 \text{ MHz}$ $V_{\text{CE}} = 4 \text{ Volts}, I_C = 5 \text{ mA}$ $V_{\text{CE}} = 10 \text{ Volts}, I_C = 10 \text{ mA}$	15 20			
Open Circuit Output Capacitance	C_{OBO}	$V_{\text{CB}} = 4 \text{ Volts}, I_E = 0 \text{ mA}, 100 \text{ kHz} < f < 1 \text{ MHz}$			2.5	pF
Open Circuit Input Capacitance	C_{IBO}	$V_{\text{EB}} = 0.5 \text{ Volts}, I_C = 0 \text{ mA}, 100 \text{ kHz} < f < 1 \text{ MHz}$			2.5	pF
Collector Base time constant	$r_b \cdot C_{\text{C}1}$ $r_b \cdot C_{\text{C}2}$	$V_{\text{CE}} = 4 \text{ Volts}, f = 31.8 \text{ MHz}$ $I_C = 5 \text{ mA}$ $I_C = 10 \text{ mA}$			60 50	ps

Switching Characteristics

Saturated Turn-On Time	t_{ON}	$V_{\text{CC}} = 17 \text{ Volts}, I_C = 10 \text{ mA}$			2.5	ns
Saturated Turn-Off Time	t_{OFF}	$V_{\text{CC}} = 17 \text{ Volts}, I_C = 10 \text{ mA}$			3.5	ns